Application/Control No. Applicant(s)/Patent Under Reexamination 10/500,573 ARUGA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 TAN N. TRAN 2826 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,074,102 06-2000 Oikawa, Yoichi 385/88 Α US-В US-С US-D US-Ε F US-G US-Н US-US-US-J US-K US-L М US-FOREIGN PATENT DOCUMENTS Document Number Country Code-Number-Kind Code Date Name Classification Country MM-YYYY N 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

٧

W

Х